

PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

PM75B4L1C060



FEATURE

- a) Adopting new 5th generation Full-Gate CSTBT™ chip
- b) Error output signal is possible from all each protection upper and lower IGBT
- c) The mounting surface is 90mm×50mm about 30% less than B4LA type

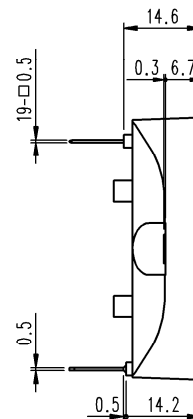
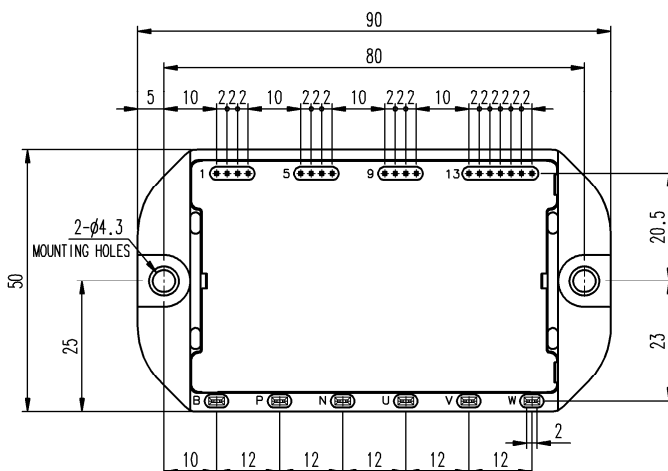
- Monolithic gate drive & protection logic
- Detection, protection & status indication circuits for, short-circuit, over-temperature & under-voltage.

APPLICATION

Photo voltaic power conditioner

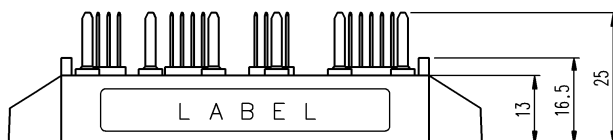
PACKAGE OUTLINES

Dimensions in mm



Terminal code

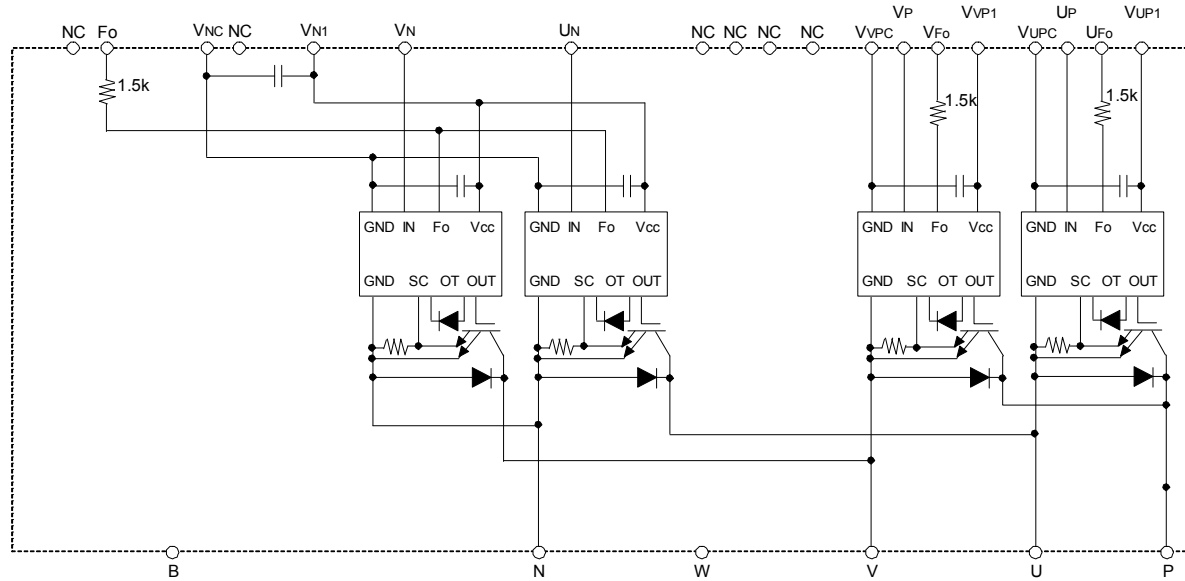
1. VUPC	8. VVP1	15. NC
2. UFo	9. NC	16. UN
3. UP	10. NC	17. VN
4. VUP1	11. NC	18. NC
5. VVPC	12. NC	19. Fo
6. VFo	13. VNC	
7. VP	14. VN1	



PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

INTERNAL FUNCTIONS BLOCK DIAGRAM



MAXIMUM RATINGS ($T_j = 25^{\circ}\text{C}$, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V_{CES}	Collector-Emitter Voltage	$V_D=15\text{V}$, $V_{CIN}=15\text{V}$	600	V
I_C	Collector Current	$T_C=25^{\circ}\text{C}$	75	A
I_{CRM}		Pulse	150	
P_{tot}	Total Power Dissipation	$T_C=25^{\circ}\text{C}$	201	W
I_E	Emitter Current (Free wheeling Diode Forward current)	$T_C=25^{\circ}\text{C}$	75	A
I_{ERM}		Pulse	150	
T_j	Junction Temperature		$-20 \sim +150$	$^{\circ}\text{C}$

*: T_C measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
V_D	Supply Voltage	Applied between : $V_{UP1}-V_{UPC}$, $V_{VP1}-V_{VPC}$, $V_{N1}-V_{NC}$	20	V
V_{CIN}	Input Voltage	Applied between : $UP-V_{UPC}$, $VP-V_{VPC}$, $UN-V_{NC}$	20	V
V_{FO}	Fault Output Supply Voltage	Applied between : $U_{FO}-V_{UPC}$, $V_{FO}-V_{VPC}$, $Fo-V_{NC}$	20	V
I_{FO}	Fault Output Current	Sink current at U_{FO} , V_{FO} , Fo terminals	20	mA

PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

TOTAL SYSTEM

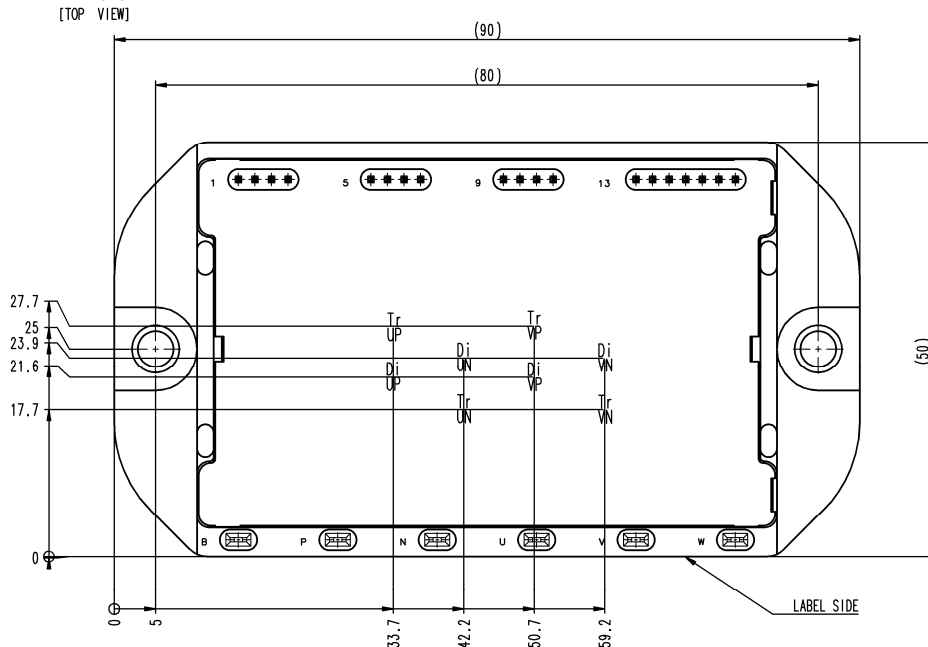
Symbol	Parameter	Conditions	Ratings	Unit
$V_{CC(Prot)}$	Supply Voltage Protected by SC	$V_D = 13.5V \sim 16.5V$ Inverter Part, $T_j = +125^\circ C$ Start	450	V
$V_{CC(surge)}$	Supply Voltage (Surge)	Applied between : P-N, Surge value	500	V
T_{stg}	Storage Temperature		-40 ~ +125	$^\circ C$
V_{isol}	Isolation Voltage	60Hz, Sinusoidal, RMS, Charged part to Base, AC 1min.	2500	V

*: T_C measurement point is just under the chip.

THERMAL RESISTANCE

Symbol	Parameter	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT (per 1 element) (Note.1)	-	-	0.62	K/W
$R_{th(j-c)D}$		Junction to case, FWDi (per 1 element) (Note.1)	-	-	1.06	
$R_{th(c-s)}$	Contact Thermal Resistance	Case to heat sink, (per 1 module) Thermal grease applied (Note.1)	-	0.06	-	

Note.1: If you use this value, $R_{th(s-a)}$ should be measured just under the chips.



ELECTRICAL CHARACTERISTICS ($T_j = 25^\circ C$, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CEsat}	Collector-Emitter Saturation Voltage	$V_D = 15V$, $I_C = 75A$ $V_{CIN} = 0V$, Pulsed (Fig. 1)	-	2.2	2.7	V
		$T_j = 25^\circ C$ $T_j = 125^\circ C$	-	2.2	2.7	
V_{EC}	Emitter-Collector Voltage	$I_E = 75A$, $V_D = 15V$, $V_{CIN} = 15V$ (Fig. 2)	-	2.4	3.3	V
t_{on}	Switching Time	$V_D = 15V$, $V_{CIN} = 0V \leftrightarrow 15V$ $V_{CC} = 300V$, $I_C = 75A$ $T_j = 125^\circ C$ Inductive Load (Fig. 3,4)	0.1	0.5	1.2	μs
t_{rr}			-	0.1	0.2	
$t_{c(on)}$			-	0.15	0.3	
t_{off}			-	1.1	2.0	
$t_{c(off)}$			-	0.2	0.4	
I_{CES}	Collector-Emitter Cut-off Current	$V_{CE} = V_{CES}$, $V_D = 15V$, $V_{CIN} = 15V$ (Fig. 5)	-	-	1	mA
		$T_j = 25^\circ C$ $T_j = 125^\circ C$	-	-	10	

PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

CONTROL PART

Symbol	Parameter	Conditions	Limits			Unit
			Min.	Typ.	Max.	
I_D	Circuit Current	$V_D=15V, V_{CIN}=15V$	-	6.5	12	mA
		$V_{N1}-V_{NC}$ $V_{P1}-V_{PC}$	-	1.6	4.0	
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between : $UP-V_{UPC}, VP-V_{VPC}, UN \cdot VN-V_{NC}$	1.2	1.5	1.8	V
$V_{th(OFF)}$	Input OFF Threshold Voltage		1.7	2.0	2.3	
SC	Short Circuit Trip Level	$-20 \leq T_J \leq 125^\circ C, V_D=15V$ (Fig. 3, 6)	112	-	-	A
$t_{off(SC)}$	Short Circuit Current Delay Time	$V_D=15V$ (Fig. 3, 6)	-	0.2	-	μs
OT	Over Temperature Protection	Detect Temperature of IGBT chip	Trip level	135	-	$^\circ C$
$OT_{(hys)}$			Hysteresis	-	20	
UV_t	Supply Circuit Under-Voltage Protection	$-20 \leq T_J \leq 125^\circ C$	Trip level	11.5	12.0	V
UV_r			Reset level	-	12.5	
$I_{FO(H)}$	Fault Output Current	$V_D=15V, V_{FO}=15V$ (Note.2)	-	-	0.01	mA
$I_{FO(L)}$			-	10	15	
t_{FO}	Fault Output Pulse Width	$V_D=15V$ (Note.2)	1.0	1.8	-	ms

Note.2: Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

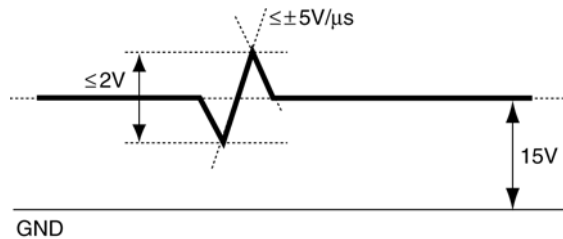
MECHANICAL RATINGS AND CHARACTERISTICS

Symbol	Parameter	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting Torque	Mounting part screw : M4	1.4	1.65	1.9	N·m
m	Weight	-	-	135	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V_{CC}	Supply Voltage	Applied across P-N terminals	≤ 450	V
V_D	Control Supply Voltage	Applied between : $V_{UP1}-V_{UPC}, V_{VP1}-V_{VPC}, V_{VN1}-V_{VNC}$ (Note.3)	15.0 ± 1.5	V
$V_{CIN(ON)}$	Input ON Voltage	Applied between : $UP-V_{UPC}, VP-V_{VPC}, UN \cdot VN-V_{NC}$	≤ 0.8	V
$V_{CIN(OFF)}$	Input OFF Voltage		≥ 9.0	
f_{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t_{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 2.0	μs
I_O	Module Operating Current	RMS	≤ 30	A

Note.3: With ripple satisfying the following conditions: dv/dt swing $\leq \pm 5V/\mu s$, Variation $\leq 2V$ peak to peak



PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

PRECAUTIONS FOR TESTING

- Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
After this, the specified ON and OFF level setting for each input signal should be done.
- When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.
(These test should not be done by using a curve tracer or its equivalent.)

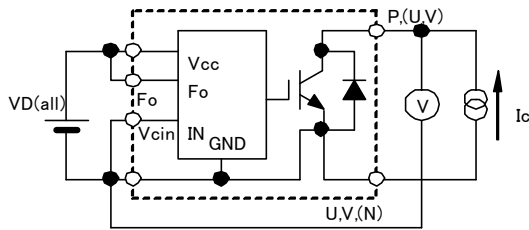


Fig. 1 V_{CESat} Test

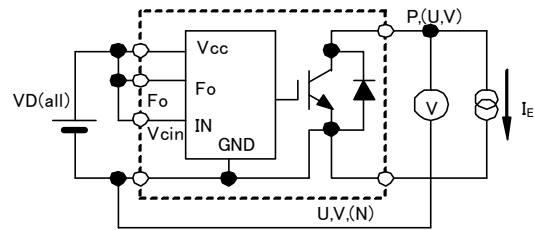


Fig. 2 V_{EC} Test

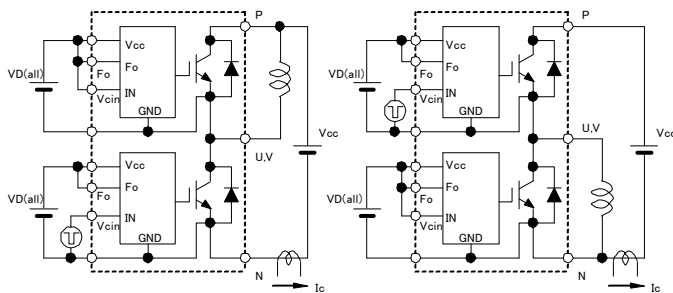


Fig. 3 Switching time and SC test circuit

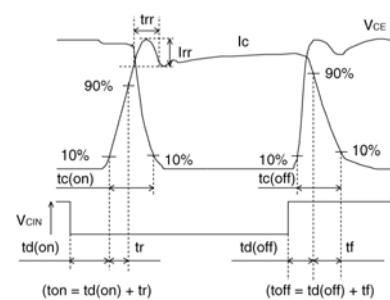


Fig. 4 Switching time test waveform

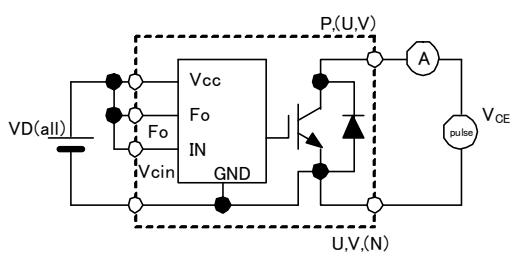


Fig. 5 I_{CES} Test

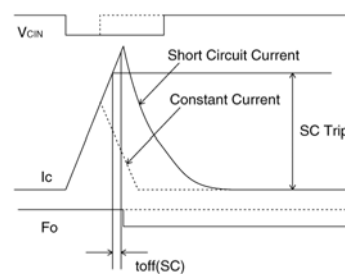
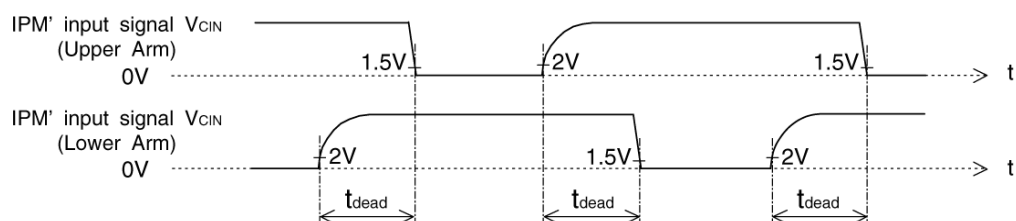


Fig. 6 SC test waveform



1.5V: Input on threshold voltage $V_{th(on)}$ typical value, 2V: Input off threshold voltage $V_{th(off)}$ typical value

Fig. 7 Dead time measurement point example

PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

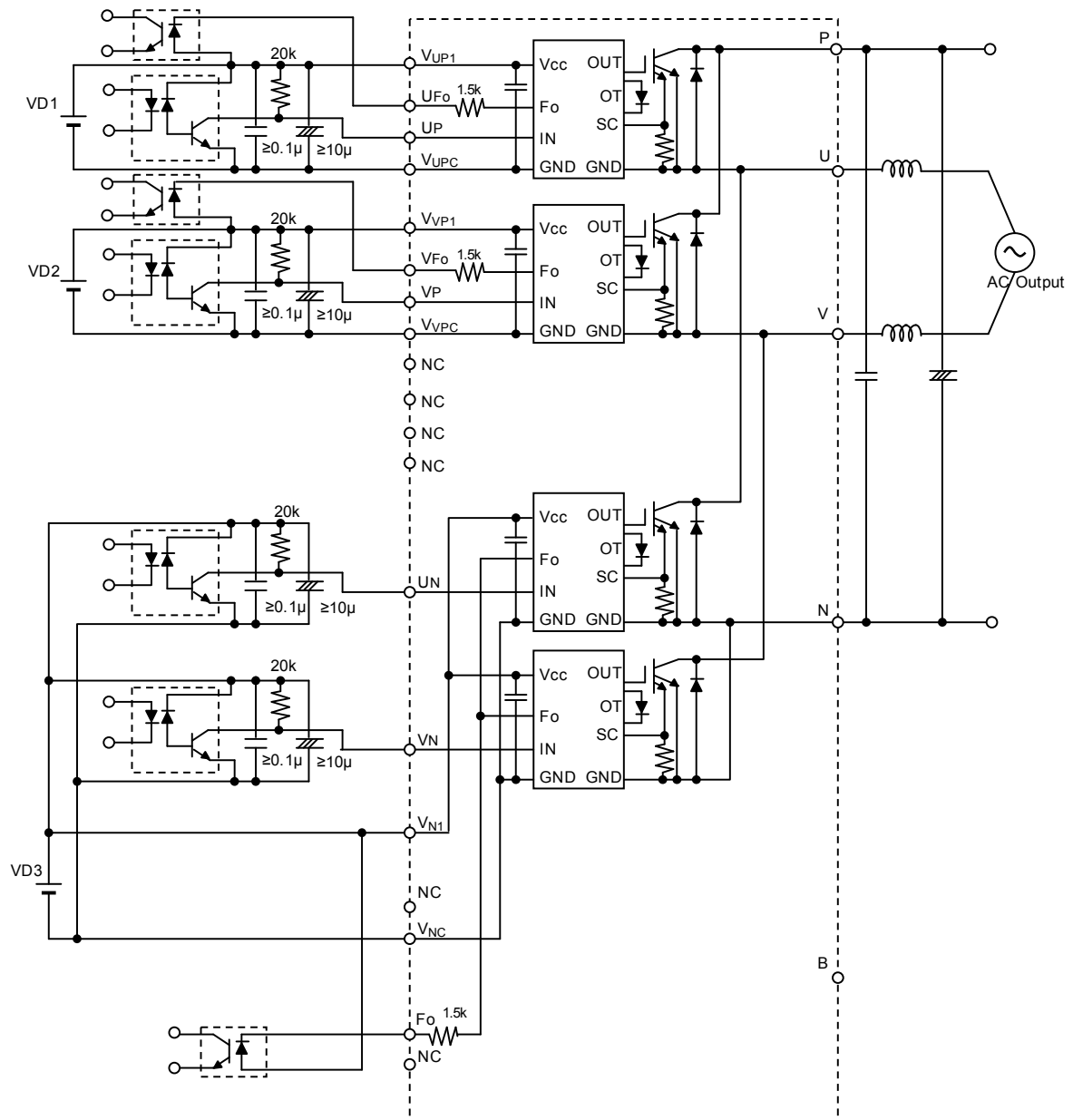


Fig. 8 Application Example Circuit

NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: $t_{PLH}, t_{PHL} \leq 0.8\mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 3 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

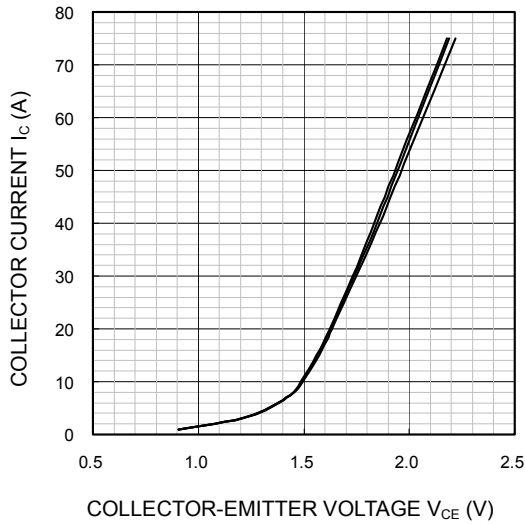
PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

PERFORMANCE CURVES

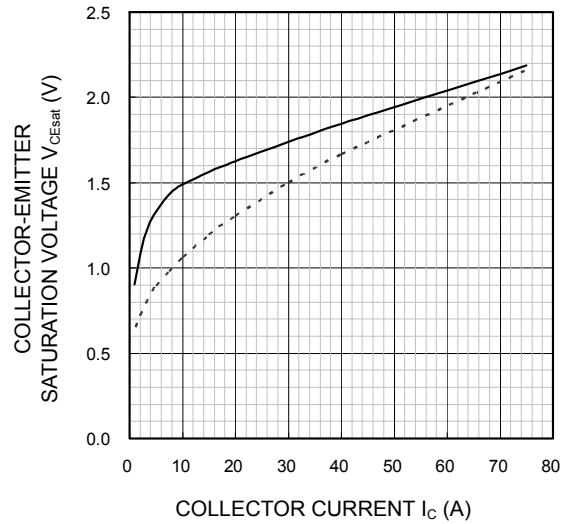
OUTPUT CHARACTERISTICS

(TYPICAL)
INVERTER PART



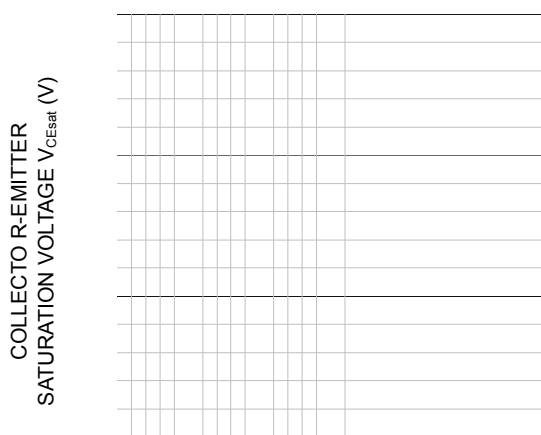
COLLECTOR-EMITTER SATURATION
VOLTAGE (VS. I_C) CHARACTERISTICS

(TYPICAL)
INVERTER PART



COLLECTOR-EMITTER SATURATION
VOLTAGE (VS. V_D) CHARACTERISTICS

(TYPICAL)
INVERTER PART



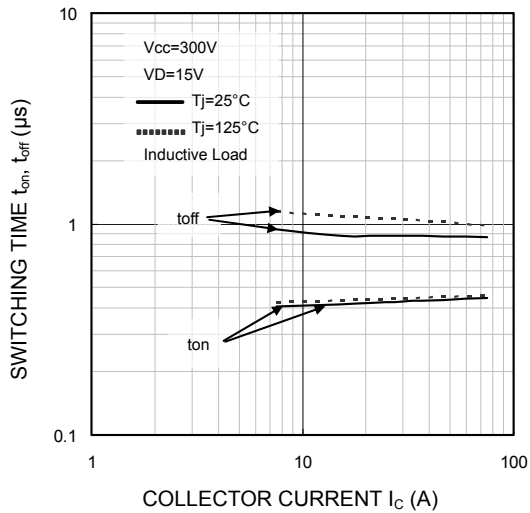
FREE WHEELING DIODE
FORWARD CHARACTERISTICS

(TYPICAL)
INVERTER PART

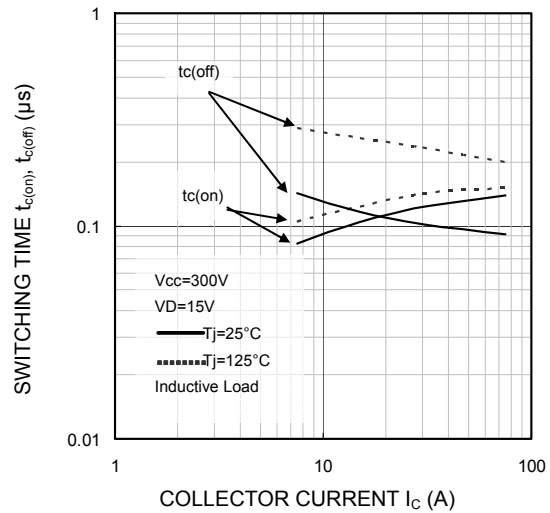
PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

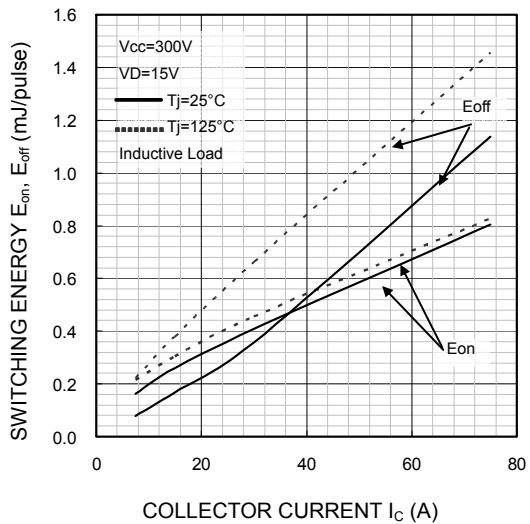
SWITCHING TIME (t_{on} , t_{off}) CHARACTERISTICS
(TYPICAL)
INVERTER PART



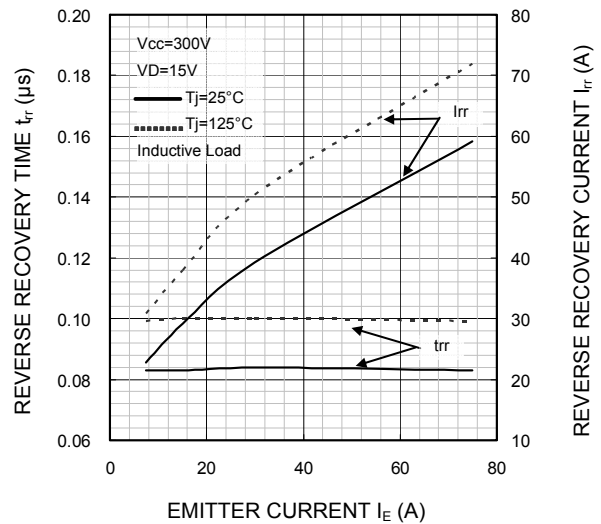
SWITCHING TIME ($t_{c(on)}$, $t_{c(off)}$) CHARACTERISTICS
(TYPICAL)
INVERTER PART



SWITCHING ENERGY CHARACTERISTICS
(TYPICAL)
INVERTER PART



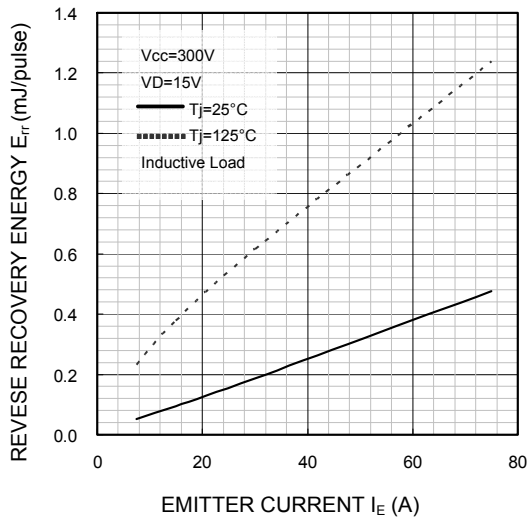
FREE WHEELING DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)
INVERTER PART



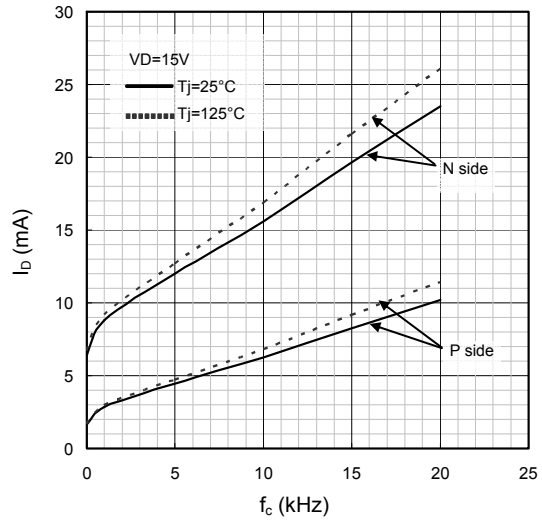
PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

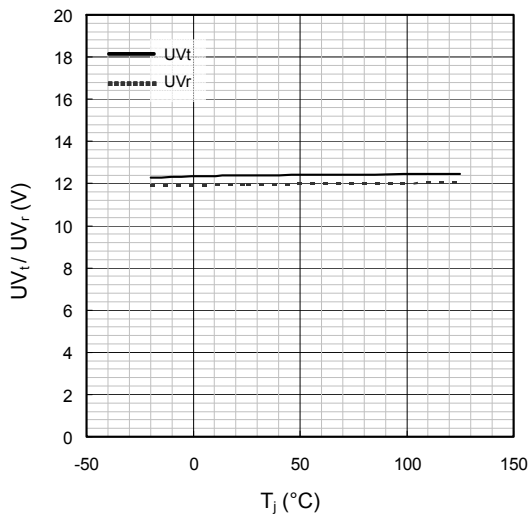
**FREE WHEELING DIODE
REVERSE RECOVERY ENERGY CHARACTERISTICS
(TYPICAL)
INVERTER PART**



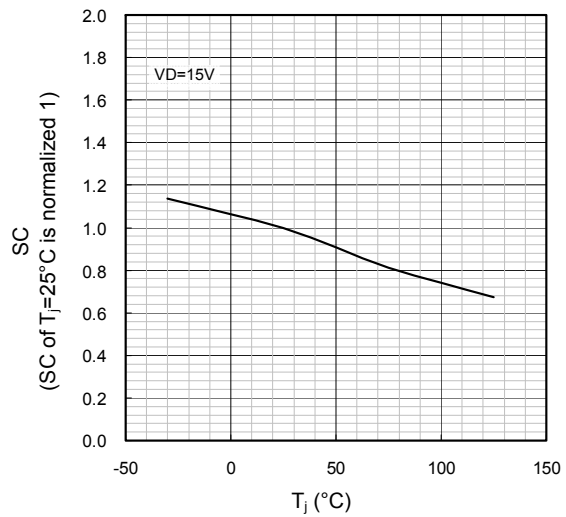
**I_b VS. f_c CHARACTERISTICS
(TYPICAL)**



**UV TRIP LEVEL VS. T_j CHARACTERISTICS
(TYPICAL)**



**SC TRIP LEVEL VS. T_j CHARACTERISTICS
(TYPICAL)
INVERTER PART**



PM75B4L1C060

FLAT-BASE TYPE
INSULATED PACKAGE

